NOTES:

- 1. SUBSTRATE: FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN <3 ARCMIN
- 3. COATING (APPLY ACROSS COATING APERTURE): S1: R(ABS) > 99% @ 532nm T(ABS) > 95% @ 1064nm @ 45° AOI

DAMAGE THRESHOLD (PULSED): 7.5 J/cm² @ 20ns , 20 Hz @ 532nm 7.5 J/cm² @ 20ns , 20 Hz @ 1064nm

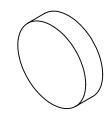
S2: R(ABS) < 0.25% @ 1064nm @ 45° AOI

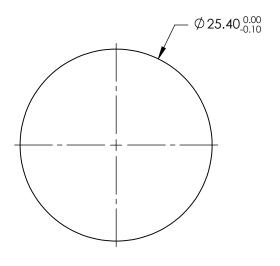
DAMAGE THRESHOLD (PULSED): 15 J/cm² @ 20ns , 20 Hz @ 1064nm

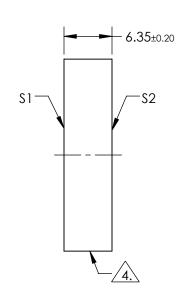


5. ROHS COMPLIANT









SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

Edward Ontice

1 OF 1

	\$1	\$2
SHAPE	PLANO	PLANO
SURFACE QUALITY	10-5	10-5
CLEAR APERTURE	Ø21.59	Ø21.59
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED

		G	Eamuna Optics®
THIRD ANGLE PROJECTION	\rightarrow	TITLE	Ø25.4mm HS 532R/1064T HARMONIC BEAMSPLITTER
ALL DIMS IN	mm	DWG NO	37715 SHEET

37715